

<b>Notice of References Cited</b>	Application/Control No. 10/004,084	Applicant(s)/Patent Under Reexamination VANTTINEN ET AL.	
	Examiner Jay P. Patel	Art Unit 2616	Page 1 of 1

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*	B	US-7,064,706 B2	06-2006	King et al.	342/357.02
*	C	US-6,826,406 B1	11-2004	Vialen et al.	455/450
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	K	US-			
	L	US-			
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	A	US-6,560,457 B1	05-2003	Silver et al.	455/445
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	C	US-6,608,832 B2	08-2003	Forslow, Jan E.	370/353
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